


Negative Group Delay Metamaterials Based on Split-Ring Resonators and Their Application

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Abstract: In this report, negative group delay (NGD) metamaterials based on split-ring resonators (SRRs) are discussed. A theoretical analysis is proposed to calculate the equivalent circuit parameters, NGD values, and S₂₁ amplitudes of two types of SRRs. Metamaterials made from tantalum nitride are simulated, and the parameters of the two types of SRRs are discussed. Prototypes of metamaterials were fabricated and tested. Measured real-world results were found to be consistent with theoretical and simulated predictions. For EC-SRR, a negative group delay of up to -0.1 ns was achieved at 12–13 GHz. For SR-SRR of the same size as the out ring of EC-SRR, a negative group delay of up to -0.04 ns was achieved, with a loss lower than 2.7 dB. The proposed SRRs were applied to continuous transverse stub (CTS) antenna to reduce the beam walk. The simulation shows that the beam walk can be reduced using the proposed metamaterial.

Keywords: negative group delay; split-ring resonator; tantalum nitride



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1. Introduction

In recent years, there has been a great deal of work devoted to metamaterials. Metamaterials have many excellent properties: low cost, easy fabrication, excellent properties, and low profile. Among the metamaterials, split-ring resonators (SRRs) are the most commonly used structures [1]. In [2], Chen et al. proposed far-field decoupling of a two-element antenna transceiving system. In [3], Huang et al. designed a multi-band SRR antenna array. In [4–6], a negative group delay (NGD) performance was achieved. In [7], Liang et al. studied strong field enhancement using SRRs. In [8], Lalbakhsh proposed an all-metal wideband metamaterial.

Since Brillouin et al. discovered NGD performance in the 1906s [9], NGD devices have been used in many systems. In [10], NGD devices were used to achieve a flat group delay response when cascaded with conventional microwave components. In [11], NGD devices were used to achieve power dividers. In [12], an amplifier using the NGD circuit to achieve group delay equalization was proposed. NGD in metamaterials was observed in a 1999 report by Pendry et al. [1], and was further discussed by Woodley et al. [5], but performance metrics such as NGD values and the relationship between parameters and loss have not been extensively studied.

In this study, equivalent circuits were proposed for both a single-ring SRR (SR-SRR) and an edge-coupled SRR (EC-SRR), both with negative group delay. The equivalent circuit parameters, especially resistance, were given and the NGD performances of these proposed circuits were then analyzed; prototypes made from Tantalum Nitride were then fabricated and tested. Additionally, the application of the SRRs to CTS antenna is discussed.

This paper is organized as follows: Section 2 describes the proposed equivalent circuit and details our analysis of its SRRs; Section 3 describes the simulated and measurement results of the SRRs; Section 4 describes the application of the SRRs; the main conclusions of this study are then summarized in Section 5.

2. Theory

2.1. Structure and Equivalent Circuit

The structures of two types of SRRs are shown in Figure 1 below.

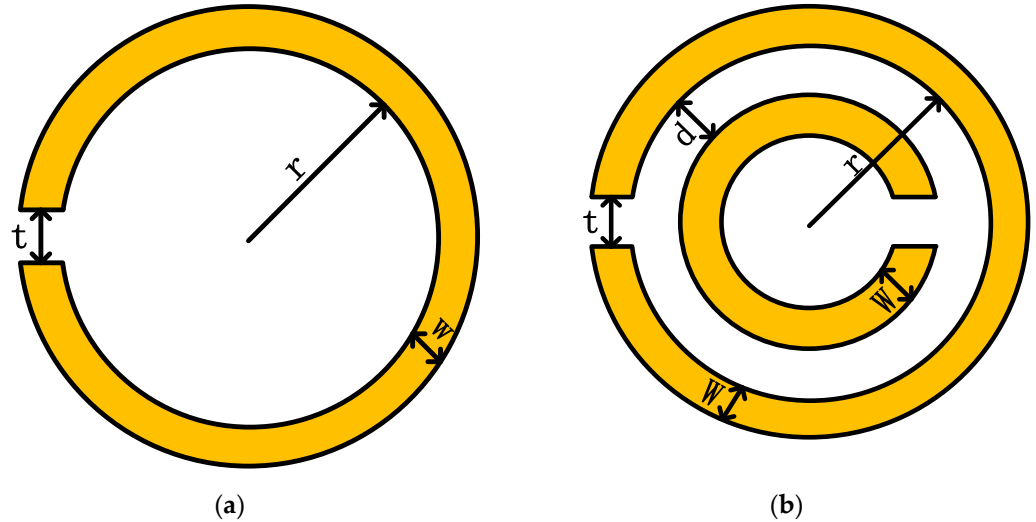


Figure 1. Diagrams of two types of SRRs: (a) single-ring SRR (SR-SRR); (b) edge-coupled SRR (EC-SRR).

These two kinds of SRRs have been studied by many researchers [1,13], and the same equivalent circuit can be obtained for them, as shown in Figure 2. A transmission line with a series resistor–inductor–capacitor (R–L–C) circuit was used to analyze them, which was consistent with our simulation and experiment setups. The inductance and capacitance (LC) parameters of SR-SRRs can be obtained [13,14] by:

$$L = \frac{\mu\pi r^2}{h} \tag{1}$$

$$C_{SR} = \frac{\epsilon Wh}{t} \tag{2}$$

where μ is the permeability, ϵ is the permittivity, r is the inner radius of the split ring, W is the width of the split ring, h is the height of the split-ring resonator, and t is the gap width. The inner radius r can be obtained using the surface resistance multiplied by the area fraction, as shown below:

$$R = R_s P = \sqrt{\frac{\omega\mu}{2\sigma}} \frac{C_{fr}\pi(r+W)^2}{a^2} \tag{3}$$

where a is the period of the metamaterial, σ is the conductivity of the surface, and $R_s = \sqrt{\frac{\omega\mu}{2\sigma}}$ is the surface resistance. P_{fr} is the area fraction constant, which can be set to 2 for the two surfaces of the metamaterial, and can be optimized if losses from other parts of the SRRs are considered.

The inductor, L , and resistor, R , of an EC-SRR are the same as for a SR-SRR, and the capacitor C can be obtained by:

$$C_{EC} = \frac{\epsilon}{\pi} \ln\left(\frac{2W}{d}\right) \tag{4}$$

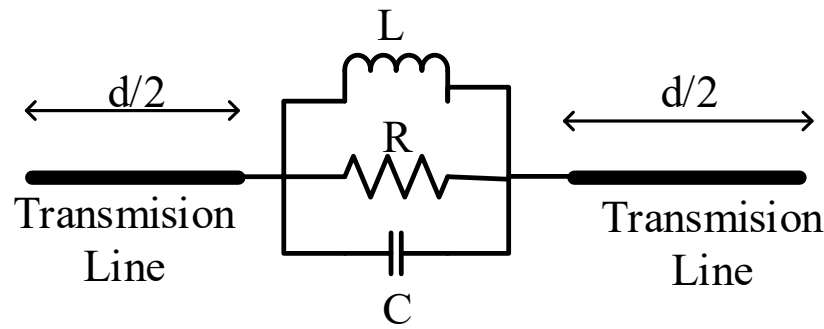


Figure 2. Equivalent circuit for split-ring resonators.

It should be noted that with a sufficiently large d value, an EC-SRR becomes equivalent to a SR-SRR, and that with a small d value, coupled capacitance is the main factor that influences the resonant frequency.

2.2. Negative Group Delay and Loss

S_{11} and S_{21} can be obtained from an ABCD matrix of the equivalent circuit as:

$$S_{11} = \frac{S_R^n + jS_I^n}{S_R^d + jS_I^d} S_{21} = \frac{2}{S_R^d + jS_I^d} \tag{5}$$

where

$$S_I^d = 2 \sin(\beta d) + \frac{wLR(R-w^2LCR)\cos(\beta d)}{(R-w^2LCR)^2+(wL)^2} + \frac{(wL)^2r \sin(\beta d)}{(R-w^2LCR)^2+(wL)^2}$$

$$S_R^d = 2 \cos(\beta d) - \frac{wLR(R-w^2LCR)\sin(\beta d)}{(R-w^2LCR)^2+(wL)^2} + \frac{(wL)^2R \cos(\beta d)}{(R-w^2LCR)^2+(wL)^2}$$

$$S_R^n = \frac{wLR(R-w^2LCR)\cos(\beta d)}{(R-w^2LCR)^2+(wL)^2} + \frac{(wL)^2R \sin(\beta d)}{(R-w^2LCR)^2+(wL)^2}$$

$$S_I^n = \frac{(wL)^2R \cos(\beta d)}{(R-w^2LCR)^2+(wL)^2} - \frac{wLR(R-w^2LCR)\sin(\beta d)}{(R-w^2LCR)^2+(wL)^2}$$

In this formula, d is the total length of the transmission line, β is the propagation constant, R is the resistance, L is the inductance, C is the capacitance, and w is the angular frequency. The amplitudes of S_{11} and S_{21} can be simplified at the resonant frequency as:

$$|S_{11}| = \frac{R}{2+R} |S_{21}| = \frac{2}{2+R} \tag{6}$$

The total loss can be obtained by:

$$Loss = 1 - |S_{21}|^2 - |S_{22}|^2 = \frac{4R}{(2+R)^2} \tag{7}$$

The loss increases proportionately with R when R is lower than 2. It should be noted that the loss is included with the return loss, but for transmission metamaterials the transmission power is more important than the absolute loss; therefore, S_{21} which is the ratio between input power and output power, is the critical parameter to evaluate.

S_{21} phase and group delays can be simplified at the resonant frequency as:

$$p_{s21} = \arctan\left(-\frac{S_I}{S_R}\right) \tag{8}$$

$$GD = \frac{\partial p_{s21}}{\partial \omega} \Big|_{w=w_0} = \frac{\partial \beta}{\partial \omega} \Big|_{w=w_0} - \frac{2CR^2}{2+R} \tag{9}$$

It can be deduced from Equations (6) and (9) that the amplitude of S_{21} is determined by R , and the group delay is determined by L and R .

3. Simulation and Measurement Results

3.1. Simulation Results

Simulations were conducted using the Ansys HFSS suite (Ansys Inc., Canonsburg, PA, USA). The simulation setup is shown in Figure 3. The TE_{00} mode was used to excite the SRRs; this is same as the transformation metamaterial setup. Teflon substrate was used to as a supporting structure which is widely used and has good electromagnetic properties and the height of which is same as the SRRs. The periodic boundary and the input floquet port are adopted which are used to simulate infinitely large structure and the edge effect can be ignored. The material used for SRRs is tantalum nitride (TaN), and the conductivity is 7400 S/m. The skin depth of the TaN at 15 GHz is 0.04 mm. Therefore, the smallest possible size of the structure should be greater than 0.04 mm and the solving inside threshold of its conductivity was set at 10,000 S/m. It should be noted that the TE_{00} mode was used in simulating the metamaterials with periodic boundaries, which is the normal input field mode of metamaterials; however, in measurement setup, the mode of the rectangular waveguide was the TE_{10} mode, which may cause a slight difference in resonant frequency compared with TE_{00} mode excitation.

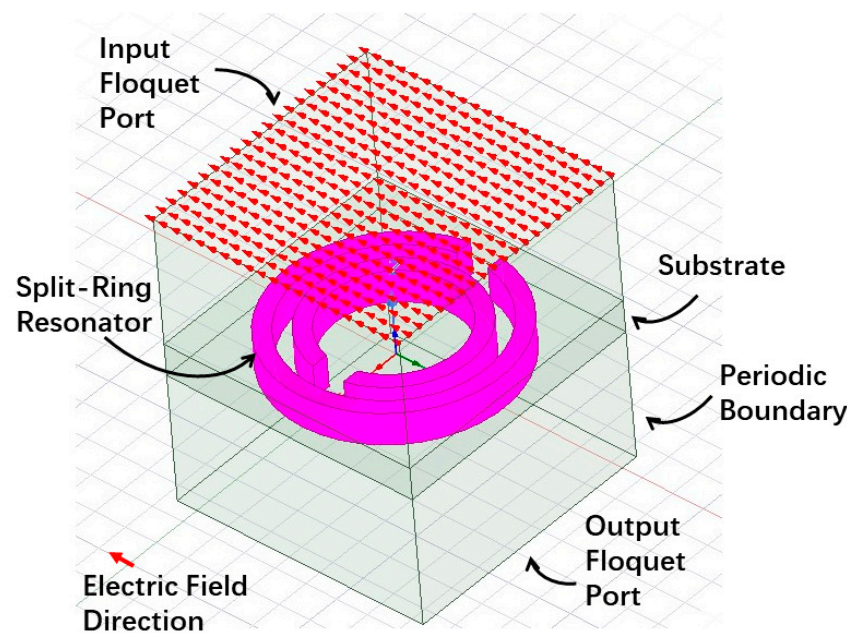


Figure 3. Simulation setup.

3.1.1. SR-SRR

It can be seen from the simulation results (Figure 4) that as w and r increase, the resonant frequency is reduced, which is due to the increase in L and C . The loss increases with the reduction in resonant frequency, which is due to the fact that when r and w increase, the area of the ring increased as well, which in turn increases the loss. When t increases, the L and C reduced and then the resonant frequency increases as well. Although the increase in t can reduce the area of the ring to some extent, the increase in the frequency of the surface resistance mainly influences the loss. Additionally, according to Equation (9), the increase in the surface resistance will increase the NGD value.

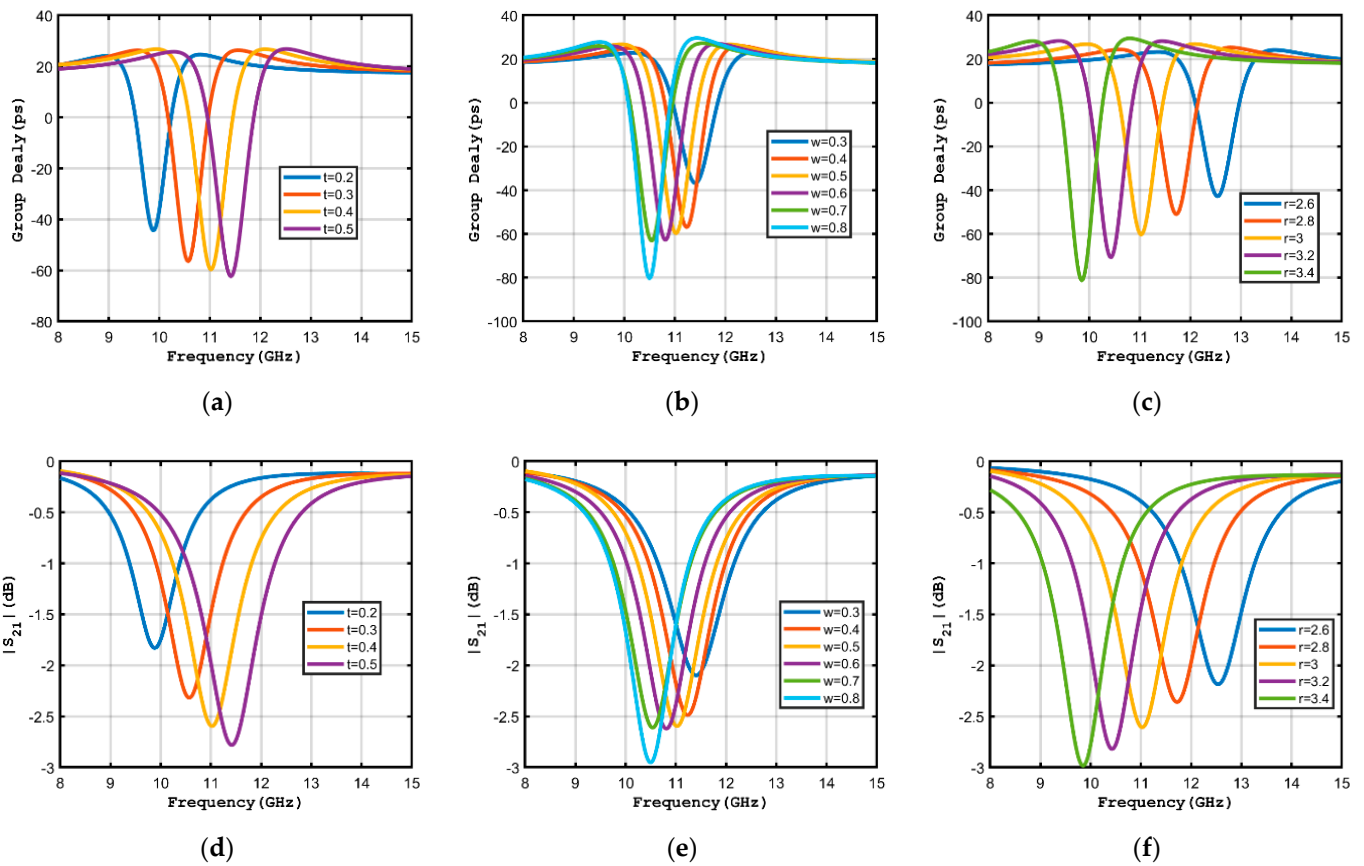


Figure 4. Simulated group delay with different (a) t , (b) w , (c) r , and S_{21} amplitudes with different amounts of (d) t , (e) w , (f) r .

3.1.2. EC-SRR

The performances of r , t , and w for EC-SRRs (Figure 5) are the same as for SR-SRRs, which can be seen from the equivalent circuit of EC-SRRs where the L term, and part of the C term, are decided by the outer ring. The only difference between the two is in the d parameter. When d increases, the coupled capacitance between the rings is reduced and the resonant frequency is reduced, which in turn decreases the surface resistance. Additionally, according to Equation (9), the decrease in surface resistance will reduce the NGD value.

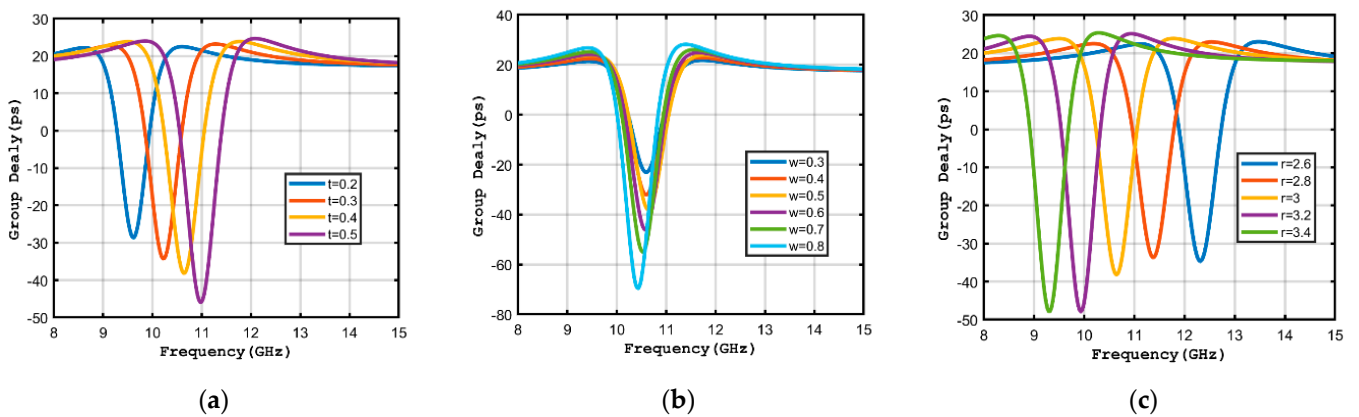


Figure 5. Cont.

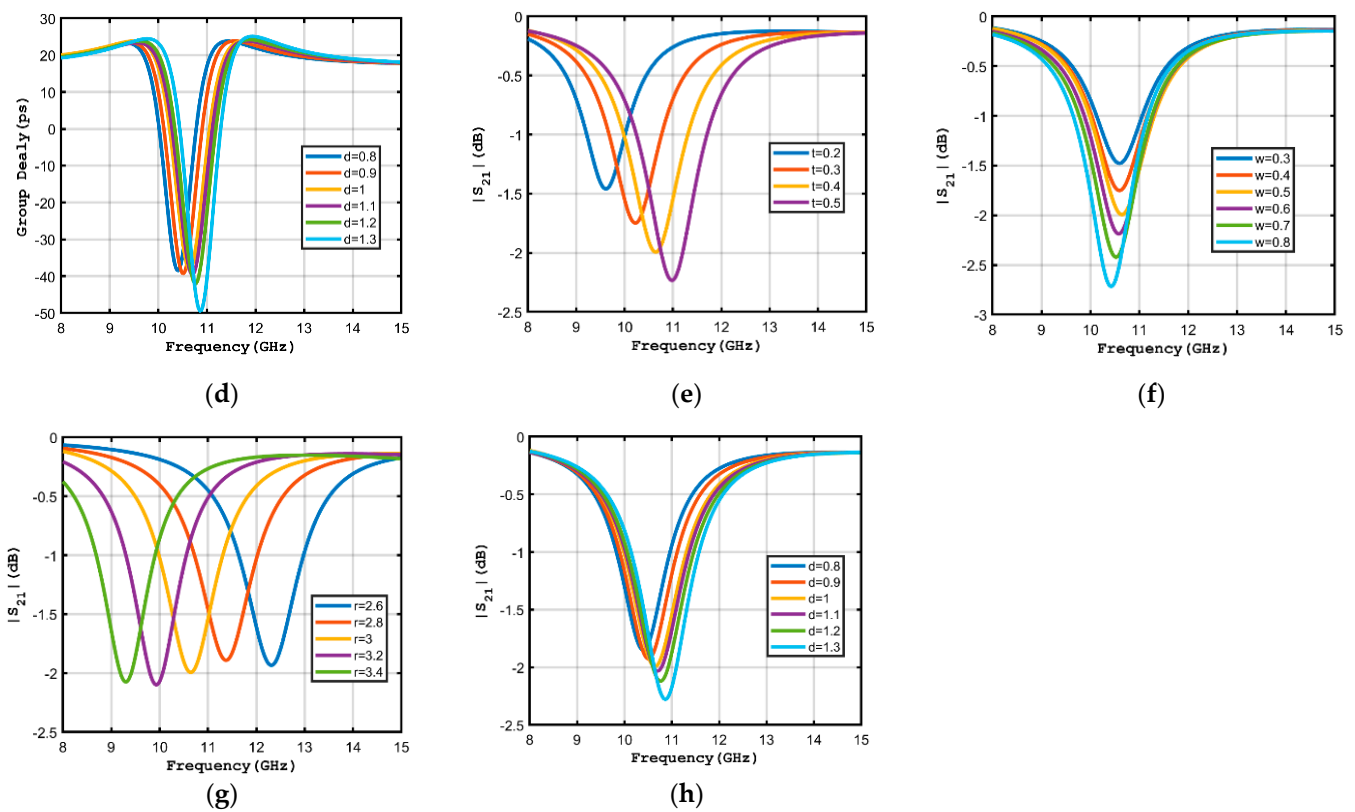


Figure 5. Simulated group delay with different (a) t , (b) w , (c) r , (d) r , and S_{21} amplitudes with different amounts of (e) t , (f) w , (g) r , (h) d .

3.2. Measured Results

The prototypes of the proposed structures were fabricated (Figure 6a) and tested using an Agilent E8364C network analyzer (Agilent Technologies Inc., Santa Clara, CA, USA) (Figure 6b). Due to the high hardness and high machining accuracy requirement of the SRRs, laser cutting was used to process the TaN material, which has a low cost in mass production. Additionally, the Teflon substrate was fabricated using computer numerical control (CNC) machining.

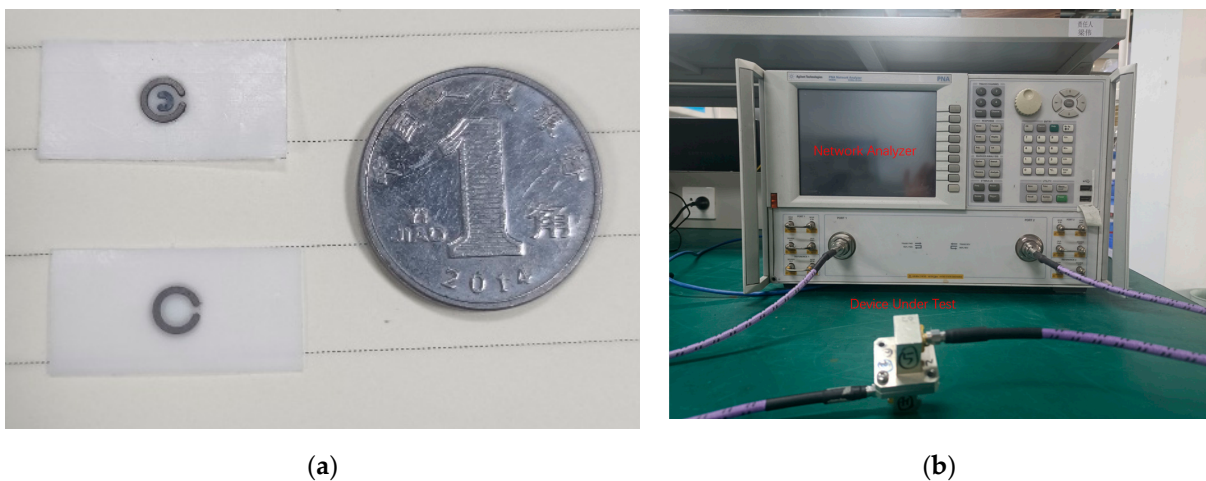


Figure 6. (a) Fabricated prototype structures and (b) measurement setup.

The metamaterials were put into the same type of WR75 rectangular waveguide used [1], in their 1999 report which is a widely used measurement setup. The parameters used were: $t = 0.5$ mm, $r = 1.3$ mm, $w = 0.5$ mm, $h = 0.3$ mm, and $d = 0.5$ mm. The simulated

and measured results are shown in Figures 7 and 8, respectively, to illustrate the consistency between them. The simulation was performed in the waveguide condition. The small observed differences may be attributable to the Teflon substrate used in the real-world test, of which the dielectric constant is not stable. The cut-off frequency of WR75 waveguide is 10 GHz, and the S21 and group delay performance below 10 GHz should be ignored. It can be seen from Figures 7 and 8 that with the same outer ring dimension, the S21 of the EC-SRR was lower than that of the SR-SRR, due to the reduction in the resonant frequency. The measured S11 was also consistent with the theoretical and simulated predictions.

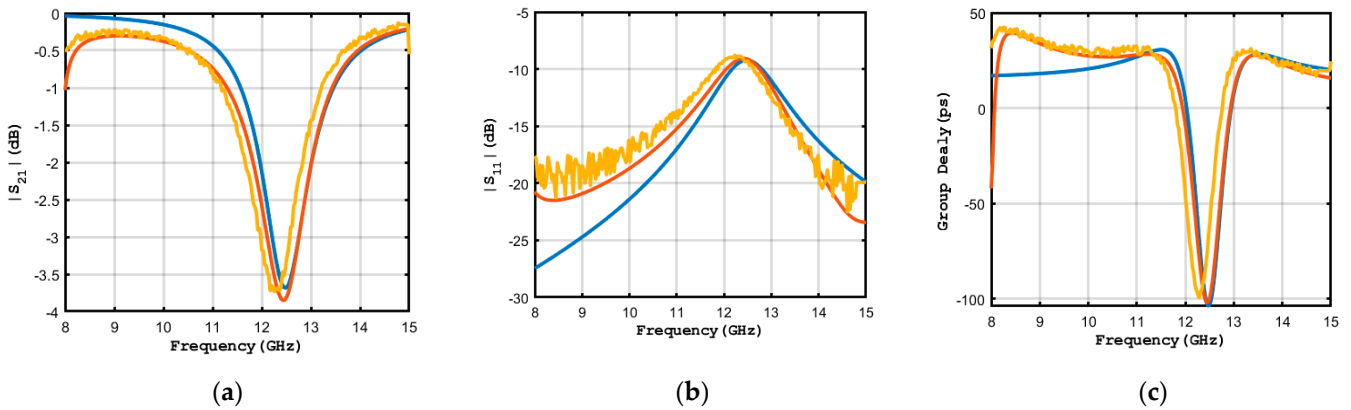


Figure 7. Measurements of the fabricated SR-SRR: (a) measured S21, (b) measured S11, (c) measured group delay.

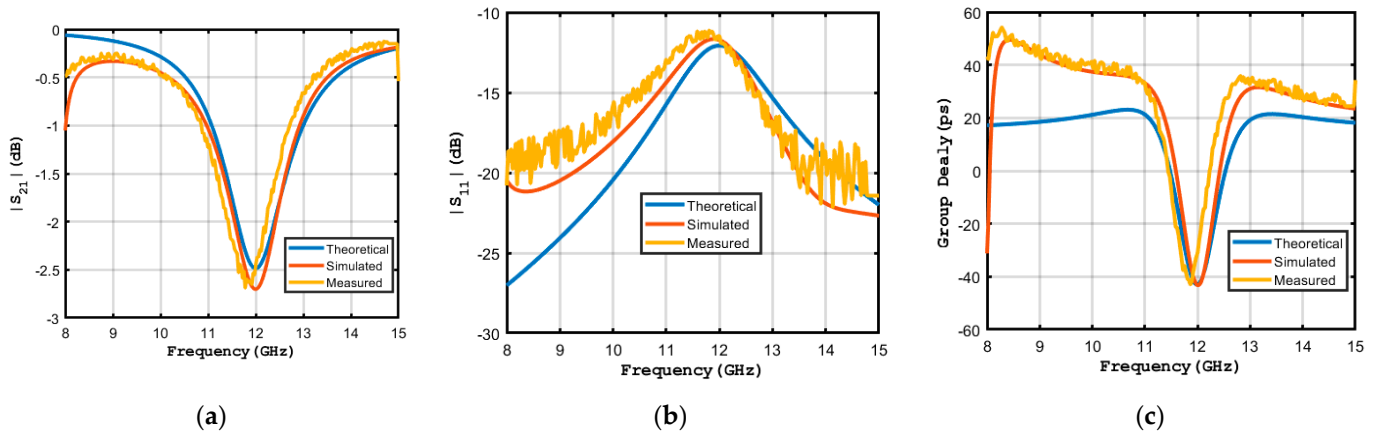


Figure 8. Measurements of the fabricated EC-SRR. (a) Measured S21, (b) measured S11, (c) measured group delay.

4. Application

The structure of continuous transverse stub (CTS) antenna is shown in Figure 9. The antenna comprises two layers: radiation and waveguide layers. The radiation layer is composed of transverse stubs. The electromagnetic power radiates from the slots between the stubs. The waveguide layer and the radiation layer form a parallel plate waveguide structure and antenna aperture.

The beam direction of CTS antenna with θ can be detected by

$$k \sin(\theta)p + k\sqrt{\epsilon_g}p = 2\pi \tag{10}$$

where θ is the elevation angle, λ is the wavelength, ϵ_g is the effective dielectric constant, k is the propagation constant in free space and p is the slot period.

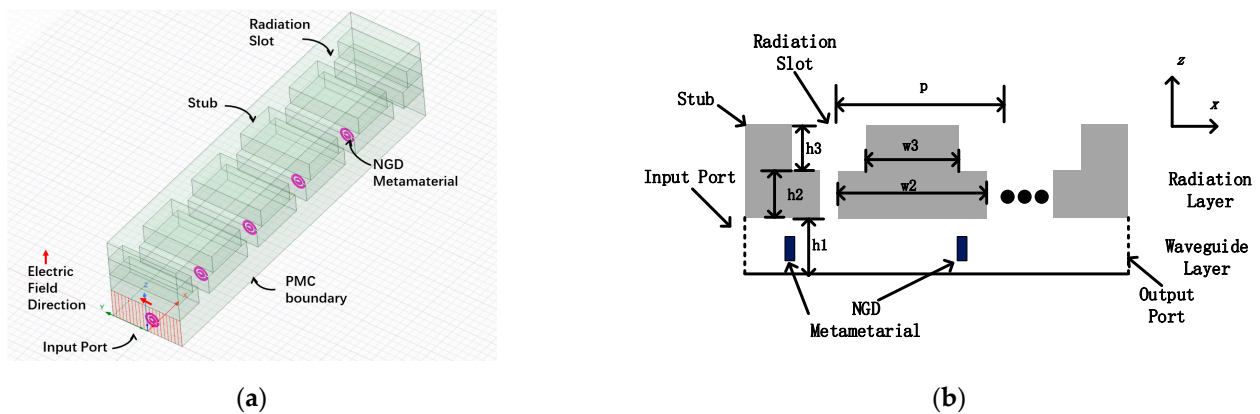


Figure 9. Diagrams of CTS antenna: (a) three-dimensional perspective and (b) side view.

It can be seen from Equation (10) that as the frequency increases the beam direction moves closer to the normal direction. The frequency scanning is caused by the time delay between each slot. Therefore, the NGD can be introduced to reduce the frequency scanning. NGD metamaterial can be placed in the waveguide layer or below the radiation layer, but here only the waveguide situation is discussed and EC-SRR was used. It should be noted that the metamaterial element period should be same as the slot period and the NGD value and frequency should be adjusted using the metamaterial parameters.

Simulations of the proposed CTS antenna were conducted using the Ansys HFSS suite (Ansys Inc., Canonsburg, PA, USA). The boundaries of the two sides are set using the perfect magnetic conductor (PMC), which are the same as for the CTS antenna, and the TEM mode is generated in the waveguide. For the CTS antenna, the TEM mode feed can be achieved by linear source generator. CTS antenna with five slots was simulated. The parameters were $h_1 = 8$ mm, $h_2 = 5$ mm, $h_3 = 5$ mm, $p = 19$ mm, $h_2 = 5$ mm, $w_2 = 15$ mm, $w_3 = 11$ mm, $r = 1.5$ mm, $t = 0.5$ mm, $w = 0.5$ mm, $h = 0.1$ mm, and $d = 0.5$ mm.

The simulated E-plane patterns of the CTS antenna are shown in Figure 10. The beam walk reduction can be observed. The simulated S parameters are shown in Figure 11. S_{11} and S_{21} are both below -12 dB.

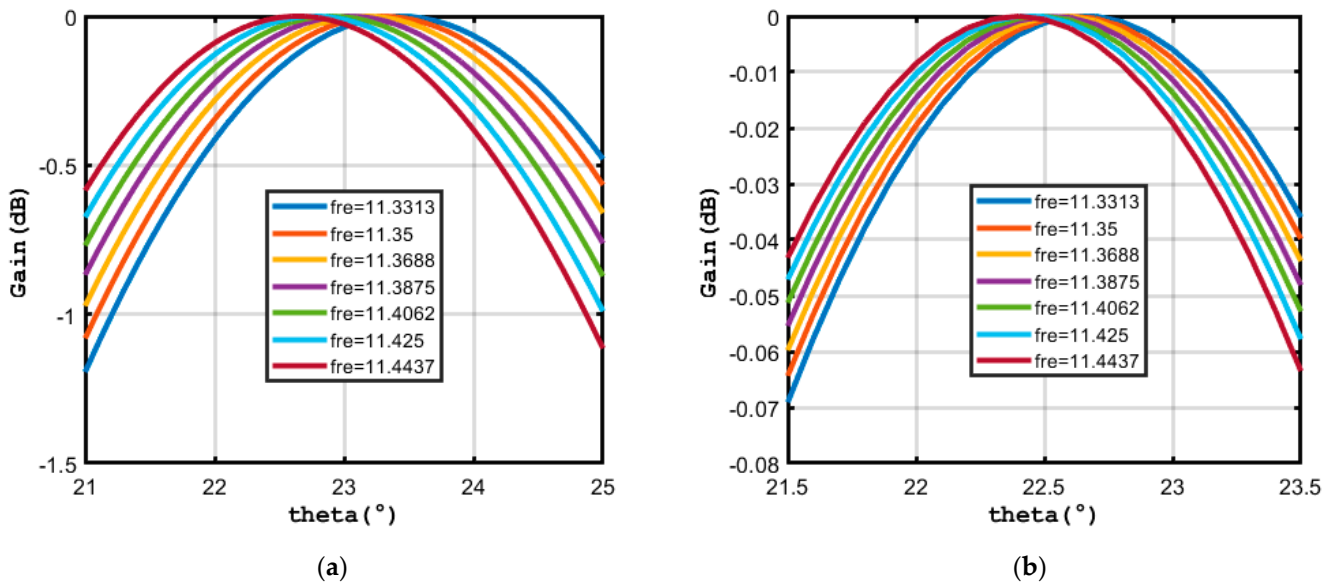


Figure 10. Simulated pattern of CTS antenna (a) without SRRs, (b) with SRRs.

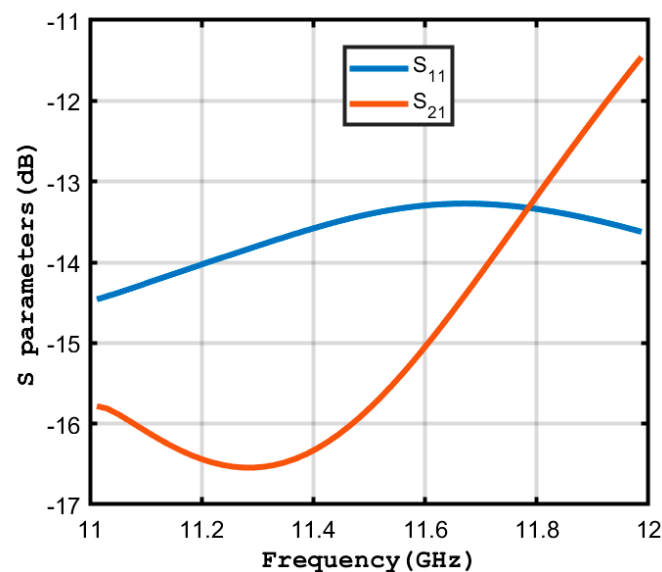


Figure 11. Simulated S parameters.

It should be noted that although the frequency scanning can be reduced with the introduction of the NGD metamaterial, the gain of the antenna also reduced. Additionally, because the gain varies with frequency, the instantaneous bandwidth may also be reduced. However, this issue can be resolved using the wideband flat NGD device.

5. Conclusions

In this report, negative group delay (NGD) metamaterials based on split-ring resonators (SRRs) were evaluated. A theoretical analysis was first performed to obtain the equivalent circuit parameters, NGD values, and S_{21} amplitudes. The parameters were then simulated and discussed, and the metamaterials were fabricated from tantalum nitride before being tested in a laboratory setting. The measured results were found to be consistent with the theoretical and simulated predictions. For EC-SRR, a negative group delay of up to -0.1 ns was achieved at 12–13 GHz. For SR-SRR of the same size as the out ring of EC-SRR, a negative group delay of up to -0.04 ns was achieved with a loss lower than 2.7 dB. The application of the metamaterial was discussed, and the frequency scanning reduction in CTS antenna was achieved using NGD metamaterials.

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